


<b>Search Notes</b> 	<b>Application/Control No.</b> 10762519	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> Fotakis, Aristocratis	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	05/21/2007	AF
Consulted with Chieh M.Fan	05/21/2007	AF
Consulted with Ted Wang	05/21/2007	AF
Consulted with Chieh M.Fan	11/07/2007	AF
EAST, IEEE, EPO, Internet Search	11/07/2007	AF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner